

Synthesis and characterisation of new Bi(III)-containing apatite-type oxide ion conductors: the influence of lone pairs

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Received 00th January 20xx,
Accepted 00th January 20xx

DOI: 10.1039/x0xx00000x

www.rsc.org/

Lone-pair cations are known to enhance oxide ion conductivity in fluorite- and Aurivillius-type materials. Among the apatite-type phases, the opposite trend is found for the more widely studied silicate oxide ion conductors, which exhibit a dramatic decrease in conductivity on Bi(III) incorporation. In this work, the influence of lone-pair cations on the properties of apatite-type germanate oxide ion conductors has been investigated by preparing and characterising seven related compositions with varying Bi(III) content, by X-ray and neutron powder diffraction and impedance spectroscopy. All materials are very good oxide ion conductors (with conductivities of up to 1.29×10^{-2} at 775°C). Increasing Bi(III) content leads to increases in conductivity by up to an order of magnitude, suggesting significant differences in the oxide-ion conduction mechanisms between lone-pair containing apatite-type germanate and silicate solid electrolytes.

Introduction

Apatite-type germanates and silicates of the general formula $A_{10}(TO_4)_6O_{2\pm\delta}$, (A = alkaline or rare earth, Pb, Bi etc.; T = Ge, Si) display high oxide ion conductivities in the so-called intermediate-temperature solid oxide fuel cell (IT-SOFC) region between 450 and 600 °C.¹⁻¹² There has been considerable research effort to understand the oxide ion conductivity mechanisms and, on this basis, optimise the composition and properties of these materials.¹³⁻¹⁶ The number and locations of any interstitial oxide ions are crucial for the conductivity, and are still debated in the literature.^{7, 13-25}

Another important aspect of the structure-property relationships in apatite solid electrolytes is the influence of lone-pair cations. In several different families of materials, most notably in fluorite- and Aurivillius-type phases, lone pairs are thought to enhance conductivity by providing a highly polarisable cation sublattice for the oxide ions to hop through.²⁶⁻³⁰ The effect of potential Bi(III)-doping on oxide ion conductivity in apatites is presumed to be detrimental, due to assumption that the lone pairs are located so that they point towards the centre of the channel in the apatite structure, and suppress the O²⁻ mobility within the channel. However, there are relatively few Bi(III)-containing apatites reported in the literature, and even fewer reports of oxide ion conductivity measurements. Zhuravlev *et al.* reported the preparation of three phases in the $Bi_2Ca_{8-2x}La_{2x}[(VO_4)_{6-2x}(GeO_4)_{2x}]O_2$ ($x = 1, 2, 3$) series without any physical property measurements.³¹ More recently, we reported the synthesis and characterisation of

$Bi_2La_8[(GeO_4)_6]O_3$, a triclinic apatite which undergoes a reversible phase transition into the hexagonal structure near 680°C and reaches oxide ion conductivity the same as that of yttria-stabilised zirconia at 800°C.³²

In this work, we report the preparation and characterisation of a series of lone-pair-containing apatite-type materials with varying Bi(III) content by powder diffraction methods (laboratory X-ray diffraction, synchrotron X-ray diffraction, neutron diffraction) and conductivity measurements.

Experimental

Sample preparation

All samples were prepared by conventional solid state synthesis. The reagents used were: Bi₂O₃ (Sigma-Aldrich, 99.90%), CaCO₃ (BDH, 99.50%), GeO₂ (Sigma-Aldrich, 99.99%), La₂O₃ (Sigma-Aldrich, 99.99%) and V₂O₅ (Sigma-Aldrich, 99.99%). Prior to use as a reagent, La₂O₃ was heated at 1000 °C. The synthesis temperature was 1100 °C and heating durations were between 18 and 54 hours, with heating and cooling rates of 5 °C per minute.

Characterisation

Room-temperature powder X-ray diffraction (PXRD) data were collected on a Bruker AXS D8 Advance diffractometer with Cu K α radiation and a Lynx-Eye detector. Synchrotron PXRD data were collected on the Powder Diffraction Beamline at the Australian Synchrotron.³³ The samples were finely ground and placed into 0.2 mm diameter quartz capillaries which were rotated during data collection. Data were collected in a 2θ range of 3 to 83 ° using a monochromated X-ray beam ($\lambda = 0.6354$ Å, calibrated against NIST SRM660b LaB₆) and a Mythen II microstrip detector. Each data set was collected with the detector in two different positions offset by 0.5 ° to cover gaps

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in the angular range of the modular detector strip, with a collection time of 900 seconds per position. The two collected data sets were then combined into a single diffraction pattern using the PDViPer software. Neutron diffraction data were collected on the ECHIDNA powder neutron diffractometer on the OPAL reactor at ANSTO.³⁴ For each data collection, approximately 8 g of powdered sample was placed into a 9 mm diameter vanadium can and data were collected over the 2θ range of 6 to 164° , with the wavelength of the neutrons fixed at $2.4395(5)$ Å using the [331] reflection of a Ge monochromator. No additional collimation was applied. All powder diffraction data were analysed using the Topas Academic software.³⁵

AC impedance spectroscopy measurements were carried out in air using a Solartron 1260 frequency response analyser over a 10^6 to 10^{-1} Hz frequency range. The circular faces of the sintered pellet were coated with a fine layer of Pt paste and affixed in a Probostat A-6 measurement cell. The coated pellets were fired at 800°C for 1 hr to eliminate the organic components from the paste to form electrodes. The impedance data were collected on heating in temperature intervals of 50°C for all samples except for $\text{Bi}_2\text{La}_8[(\text{GeO}_4)_6]\text{O}_3$, for which a temperature step of 25°C was used, with a heating rate of $5^\circ\text{C}/\text{min}$. Before data collection, the pellet was thermally stabilised for 45 mins. The complex impedance data were analysed using the Zview 3.0a software package.

Results and discussion

Structural characterisation

$\text{Bi}_2\text{Ca}_6\text{La}_2[(\text{VO}_4)_4(\text{GeO}_4)_2]\text{O}_2$, $\text{Bi}_2\text{Ca}_4\text{La}_4[(\text{VO}_4)_2(\text{GeO}_4)_4]\text{O}_2$, and $\text{Bi}_2\text{Ca}_2\text{La}_6[(\text{GeO}_4)_6]\text{O}_2$ were previously characterised by PXRD and Raman spectroscopy.³¹ In the absence of any additional (synchrotron, neutron) diffraction data on these materials, and we used PXRD and the Rietveld method³⁶ (using the previously published models) only to confirm the preparation of single-phase materials suitable for physical property measurements. The Rietveld fits obtained shown in Fig. 1 demonstrate this.

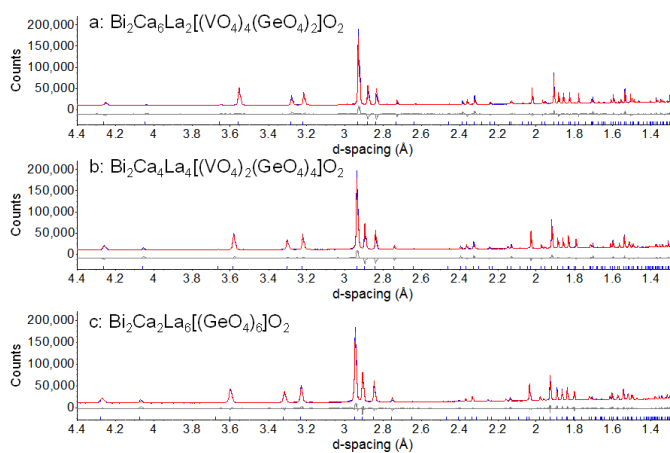


Fig. 1: Rietveld refinements for: a) $\text{Bi}_2\text{Ca}_6\text{La}_2[(\text{VO}_4)_4(\text{GeO}_4)_2]\text{O}_2$, $a = 9.8378(1)$ Å, $c = 7.1196(1)$ Å, $R_{\text{wp}} = 4.128\%$; b) $\text{Bi}_2\text{Ca}_4\text{La}_4[(\text{VO}_4)_2(\text{GeO}_4)_4]\text{O}_2$, $a = 9.8473(1)$ Å, $c = 7.1709(1)$ Å, $R_{\text{wp}} = 3.671\%$; c) $\text{Bi}_2\text{Ca}_2\text{La}_6[(\text{GeO}_4)_6]\text{O}_2$, $a = 9.8758(1)$ Å, $c = 7.2084(1)$ Å, $R_{\text{wp}} = 2.867\%$.

Laboratory PXRD data collected at room temperature on new materials $\text{Bi}_4\text{Ca}_4\text{La}_2[(\text{VO}_4)_2(\text{GeO}_4)_4]\text{O}_2$ and $\text{Bi}_4\text{Ca}_2\text{La}_4[(\text{GeO}_4)_6]\text{O}_2$, analysed by the Rietveld method using modified versions of the structural model reported by León-Reina et al. for $\text{La}_{9.5}[(\text{GeO}_4)_{5.5}(\text{AlO}_4)_{0.5}]\text{O}_2$ (space group $P6_3/m$),¹³ confirmed that these new materials adopted hexagonal structures. A more detailed structural characterisation was then carried out using synchrotron PXRD and PND data. The starting model for the refinements was the hexagonal form of $\text{Bi}_2\text{La}_8[(\text{GeO}_4)_6]\text{O}_3$, albeit with the interstitial oxygen content removed and the metal content initially split equally across all relevant sites according to the stoichiometry of the material. For each composition, a combined refinement of the synchrotron PXRD and PND data sets was undertaken with the following parameters refined: background, lattice parameters, independent isotropic temperature factors for each crystallographic site, all atomic coordinates, metal-site occupancies, scale factors, peak-shape terms (PND) and size-strain terms (synchrotron PXRD). The metal site occupancies were restrained to maintain the correct overall stoichiometry, but were allowed to refine freely across the A1 and A2 sites. The $\text{Bi}_4\text{Ca}_4\text{La}_2[(\text{VO}_4)_2(\text{GeO}_4)_4]\text{O}_2$ sample contains a small percentage of $\text{Bi}_4\text{V}_2\text{O}_{11}$, and so two lattice parameters and one overall isotropic temperature factor were refined for this impurity phase, whilst $\text{Bi}_4\text{Ca}_2\text{La}_4[(\text{GeO}_4)_6]\text{O}_2$ contains a small amount of Bi_2GeO_5 , so three lattice parameters and one overall isotropic temperature factor were refined for this phase. The structural parameters obtained are given in Tables 1 and 2 and the final fits to the data sets are presented in Fig. 2.

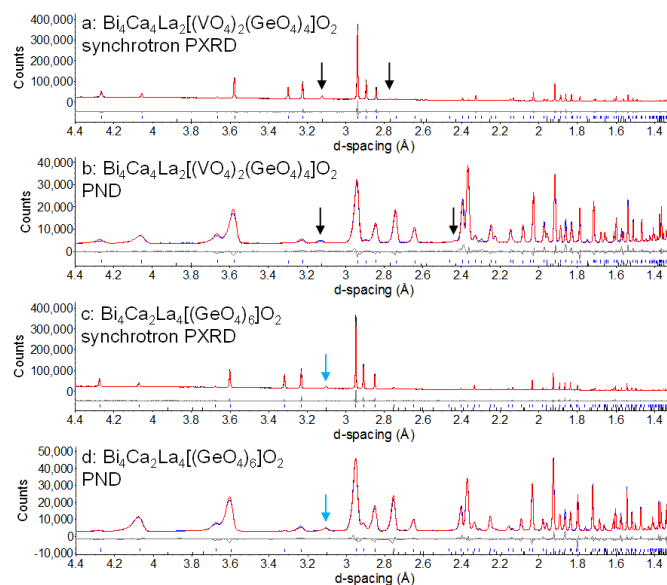


Fig. 2: Rietveld fits for $\text{Bi}_4\text{Ca}_4\text{La}_2[(\text{VO}_4)_2(\text{GeO}_4)_4]\text{O}_2$ ($a = 9.84710(5)$ Å, $c = 7.15231(4)$ Å) at room temperature to: a) synchrotron PXRD data, $R_{\text{wp}} = 4.642\%$; b) PND data, $R_{\text{wp}} = 5.755\%$. The peak positions for the $\text{Bi}_4\text{V}_2\text{O}_{11}$ impurity phase are denoted with black tick marks and the impurity peaks with black arrows. Rietveld fits for $\text{Bi}_4\text{Ca}_2\text{La}_4[(\text{GeO}_4)_6]\text{O}_2$ ($a = 9.86970(4)$ Å, $c = 7.19700(4)$ Å) at room temperature to: c) synchrotron PXRD data, $R_{\text{wp}} = 4.804\%$; d) PND data, $R_{\text{wp}} = 7.490\%$. The peak positions for the Bi_2GeO_5 impurity phase are denoted with black tick marks and the impurity peaks with blue arrows.

Table 1: Crystallographic data for hexagonal $\text{Bi}_4\text{Ca}_2\text{La}_2[(\text{VO}_4)_2(\text{GeO}_4)_4]\text{O}_2$ at 30 °C. Space group $\text{P6}_3/\text{m}$, $a = 9.84710(5)$ Å, $c = 7.15231(4)$ Å, $V = 600.612(7)$ Å³.

Site	Atom	x	y	z	Occ	B_{iso} (Å ²)
A1	Ca	1/3	2/3	0.4889(3)	0.80(1)	1.19(6)
A1	Bi	1/3	2/3	0.4889(3)	0.204(4)	1.19(6)
A2	La	0.2354(1)	0.0060(2)	1/4	0.33(1)	2.04(3)
A2	Ca	0.2354(1)	0.0060(2)	1/4	0.13(1)	2.04(3)
A2	Bi	0.2354(1)	0.0060(2)	1/4	0.533(6)	2.04(3)
T1	Ge	0.4002(2)	0.3779(2)	1/4	2/3	0.48(3)
T1	V	0.4002(2)	0.3779(2)	1/4	1/3	0.48(3)
O1	O	0.3241(2)	0.4966(2)	1/4	1	0.79(5)
O2	O	0.6034(2)	0.4687(2)	1/4	1	1.50(5)
O3	O	0.3329(2)	0.2442(2)	0.0678(2)	1	2.11(4)
O4	O	0	0	1/4	1	5.1(1)

Table 2: Crystallographic data for hexagonal $\text{Bi}_4\text{Ca}_2\text{La}_2[(\text{GeO}_4)_6]\text{O}_2$ at 30 °C. Space group $\text{P6}_3/\text{m}$, $a = 9.86970(4)$ Å, $c = 7.19700(4)$ Å, $V = 607.142(6)$ Å³.

Site	Atom	x	y	z	Occ	B_{iso} (Å ²)
A1	La	1/3	2/3	0.4917(3)	0.31(1)	1.46(6)
A1	Ca	1/3	2/3	0.4917(3)	0.50(1)	1.46(6)
A1	Bi	1/3	2/3	0.4917(3)	0.20(1)	1.46(6)
A2	La	0.2349(1)	0.0019(2)	1/4	0.46(1)	1.61(4)
A2	Bi	0.2349(1)	0.0019(2)	1/4	0.54(1)	1.61(4)
T1	Ge	0.4022(2)	0.3773(1)	1/4	1	0.45(3)
O1	O	0.3224(2)	0.4968(2)	1/4	1	0.85(5)
O2	O	0.6043(2)	0.4709(2)	1/4	1	2.08(6)
O3	O	0.3350(2)	0.2440(2)	0.0663(2)	1	2.60(4)
O4	O	0	0	1/4	1	5.4(1)

The structures of these two materials is similar to that of the hexagonal $\text{Bi}_2\text{La}_8[(\text{GeO}_4)_6]\text{O}_3$: a framework of $[(\text{A}1)_4][(\text{TO}_4)_6]$ surrounding $(\text{A}2)_6\text{O}_2$ units ($\text{A} = \text{Bi}/\text{Ca}/\text{La}$, $\text{T} = \text{V}/\text{Ge}$), with the Bi atoms favouring the channel site (A2) predominantly, whilst the Ca atoms prefer the framework site (A1), Fig. 2. The same site preferences were observed in the structure of $\text{Bi}_2\text{Ca}_8[(\text{VO}_4)_6]\text{O}_2$, determined from single-crystal diffraction data, which shows Bi favouring the channel site whilst the Ca atoms occupy primarily the framework sites.³⁷

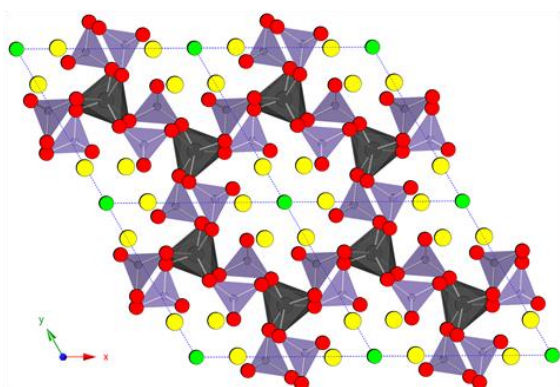


Fig. 3: The $[\text{A}1]_4[\text{A}2]_6[(\text{TO}_4)_6][\text{O}_2]$ apatite structure viewed along the z axis. Black = framework A1 sites, yellow = channel A2 sites, red = framework O, green = channel O. Bonds to the A2 and the channel O sites have been omitted for clarity.

Table 3: Bond valence sums for $\text{Bi}_4\text{Ca}_2\text{La}_2[(\text{GeO}_4)_6]\text{O}_2$ and $\text{Bi}_4\text{Ca}_2\text{La}_2[(\text{VO}_4)_2(\text{GeO}_4)_4]\text{O}_2$. The values in square brackets are those expected for the site based on the ratio of M^{2+} and M^{3+} cations.

$\text{Bi}_4\text{Ca}_2\text{La}_2[(\text{GeO}_4)_6]\text{O}_2$		$\text{Bi}_4\text{Ca}_2\text{La}_2[(\text{VO}_4)_2(\text{GeO}_4)_4]\text{O}_2$	
Site	Valence	Site	Valence
A1	2.36(1) [2.53]	A1	2.03(1) [2.25]
A2	2.68(1) [3.00]	A2	2.62(1) [2.87]
T1	4.16(1) [4.00]	T1	4.57(2) [4.33]

Bond valence sums calculated for these materials (Table 3) are consistent with our previous finding, based on $\text{Bi}_2\text{La}_8[(\text{GeO}_4)_6]\text{O}_3$, that there is not a simple relationship between the bonding requirements expressed through bond valence sums, and symmetry lowering in apatites, at least for the Bi(III)-containing phases.³² Relative to the bond valence sums expected, the A-sites are under-bonded and the T-sites over-bonded both in $\text{Bi}_4\text{Ca}_2\text{La}_2[(\text{GeO}_4)_6]\text{O}_2$ and $\text{Bi}_4\text{Ca}_2\text{La}_2[(\text{VO}_4)_2(\text{GeO}_4)_4]\text{O}_2$, and yet, both materials are hexagonal instead of distorting into triclinic structures to alleviate this. Our on-going X-ray and neutron total scattering experiments and pair distribution function analysis of a series of germanates adopting structures belonging to different crystal systems is expected to provide a local structure based understanding of the symmetry lowering in apatite-type functional materials.

Conductivity measurements

The complex impedance spectra for all samples show a single large semi-circular arc attributed to bulk response at low temperatures, with Warburg-type electrode responses observed at frequencies below 10 Hz. A parallel resistor-capacitor model was used to treat the bulk responses, and the grain boundary and bulk responses could not be separated at high frequencies in the large impedance arc.

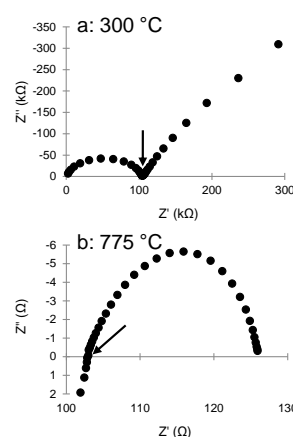


Fig. 4: Nyquist plots showing the impedance curves for $\text{Bi}_4\text{Ca}_2\text{La}_2[(\text{VO}_4)_2(\text{GeO}_4)_4]\text{O}_2$ at a) 300 °C; b) 775 °C.

The low-frequency intercepts of the semi-circular arcs arise from the bulk resistivities of the samples (marked in Fig. 4a), with capacitances calculated using $\omega\text{RC} = 1$ at 300 °C ranging between 2.20 and 4.79 pFcm^{-1} for the six materials studied,

which are consistent with bulk responses. Below 10 Hz, the calculated capacitances from the Warburg-type responses are between 10^{-7} and 10^{-5} Fcm⁻¹, indicating ionic conduction.³⁸ At high temperatures the bulk responses disappear, resulting in a single observable arc forming, and so the total resistivities of the materials are estimated from the high-frequency intercepts (marked in Fig. 4b).

The plots of the oxide-ion conductivities as a function of temperature for the compositions studied, in addition to that for the previously reported Bi₂La₈[(GeO₄)₆]O₃,³² are shown in Fig. 4, while the conductivity values at 775 °C are compared in Table 5.

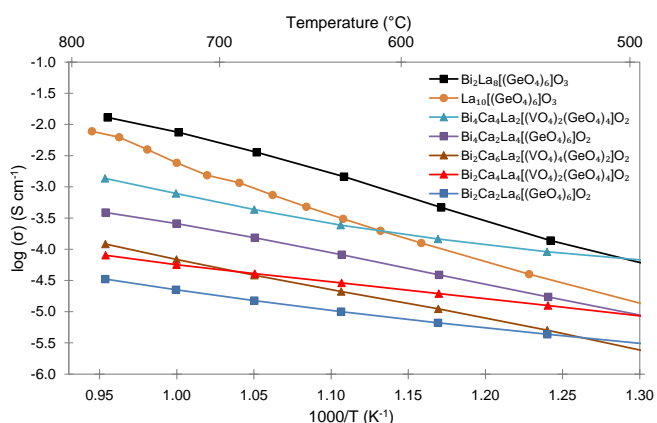


Fig. 5: Arrhenius plots of total conductivity values as a function of temperature for Bi₂La₈[(GeO₄)₆]O₃ and the related Bi(III)-containing apatite compounds studied.

Table 4: Conductivity values at 775 °C for the materials studied.

Composition	$\sigma_{775\text{ °C}}$ (Scm ⁻¹)
La ₁₀ [(GeO ₄) ₆]O ₃ *	7.77×10^{-3}
Bi ₂ La ₈ [(GeO ₄) ₆]O ₃	1.29×10^{-2}
Bi ₂ Ca ₄ La ₄ [(VO ₄) ₂ (GeO ₄) ₄]O ₂	8.04×10^{-5}
Bi ₂ Ca ₆ La ₂ [(VO ₄) ₄ (GeO ₄) ₂]O ₂	1.21×10^{-4}
Bi ₄ Ca ₄ La ₂ [(VO ₄) ₂ (GeO ₄) ₄]O ₂	1.37×10^{-3}
Bi ₂ Ca ₂ La ₆ [(GeO ₄) ₆]O ₂	3.33×10^{-5}
Bi ₄ Ca ₂ La ₄ [(GeO ₄) ₆]O ₂	3.89×10^{-4}

*785 °C

The materials studied are good oxide ion conductors, and the conductivity values measured reveal two trends. Firstly, as expected, the materials which contain extra interstitial oxygen (27 O atoms per formula unit) generally show higher conductivities than those with 26 O atoms per formula unit. The conductivities of La₁₀[(GeO₄)₆]O₃ and Bi₂La₈[(GeO₄)₆]O₃ are among the highest among the apatite-type materials. Secondly, within all three subsets of compositions, increasing the Bi content results in the increase of conductivity by up to an order of magnitude. The same trend has been found for the 800 °C conductivities of 5.5×10^{-5} Scm⁻¹ and 1×10^{-3} Scm⁻¹ reported for La₈Ba₂[(GeO₄)₆]O₂ and La₆Bi₂Ba₂[(GeO₄)₆]O₂, and 5.3×10^{-5} Scm⁻¹

and 3×10^{-3} Scm⁻¹ reported for La₈Sr₂[(GeO₄)₆]O₂ and La₆Bi₂Sr₂[(GeO₄)₆]O₂.^{4, 39}

Conclusions

In order to investigate the influence of lone-pair cations on the physical properties of apatite-type germanate oxide ion conductors, seven different compositions were prepared and characterised: the previously reported compositions La₁₀[(GeO₄)₆]O₃, Bi₂La₈[(GeO₄)₆]O₃, Bi₂Ca₆La₂[(VO₄)₄(GeO₄)₂]O₂, Bi₂Ca₄La₄[(VO₄)₂(GeO₄)₄]O₂, and Bi₂Ca₂La₆[(GeO₄)₆]O₂, and new compositions Bi₄Ca₄La₂[(VO₄)₂(GeO₄)₄]O₂ and Bi₄Ca₂La₄[(GeO₄)₆]O₂. The two new materials were structurally characterised by synchrotron X-ray and neutron diffraction, and the conductivities of all materials were determined by impedance spectroscopy. All materials are shown to be very good oxide ion conductors, stable in the temperature region investigated.

Crystallographic results demonstrate that the lone-pair containing Bi³⁺ shows a preference for the channel A-sites (A2 sites) in the apatite structure. Conductivity measurements reveal that increasing Bi³⁺ content leads to increases in conductivity by up to an order of magnitude. This is in agreement with the existing, albeit very sparse, literature on similar germanate apatites. This trend is, however, opposite to that found for the lanthanum silicate oxide-ion conductors with the apatite structure, which exhibit a dramatic decrease in conductivity on Bi(III) incorporation.⁴⁰ These results suggest significant differences in the oxide-ion conduction mechanisms in lone-pair containing apatite-type germanate and silicate solid electrolytes.

We have used a bond-valence energy landscape (BVLE) calculations method implemented in the 3DBVSMapper software^{41, 42} for preliminary assessment of likely oxide-ion migration pathways in selected materials reported here. This method provides so-called “bond valence activation energy”, which is a measure of the energy cost of connecting given crystallographic sites in the structure (via ionic migration), and as such can be used as a proxy, in relative terms, for the activation energy determined, for example, by impedance measurements. Calculations for Bi₂La₈[(GeO₄)₆]O₃ give values of 1.35 and 2.40 eV for the oxide ion migration through the apatite framework (via O²⁻ hopping between GeO₄ and GeO₅ units, which we have identified by neutron diffraction and electron microscopy³²) and for direct migration down the apatite channel, respectively. Similar relative values for these two possible pathways have been calculated for La₁₀[(GeO₄)₆]O₃, Bi₄Ca₂La₄[(GeO₄)₆]O₂ and Bi₄Ca₄La₂[(VO₄)₂(GeO₄)₄]O₂. This is in contrast to the apatite-type silicate solid electrolytes, where computational studies have reported facile diffusion down the channels.⁴³ In a separate strand of this project, we have recently been undertaking density functional theory (DFT) based molecular dynamics studies of a series of Bi(III)-containing apatite-type oxide ion conductors, which are expected to provide further and more explicit computational insight into the lone-pair effects observed experimentally and reported here.

Acknowledgements

The authors thank Durham University and ANSTO for a PhD studentship for MLT. Part of this research was undertaken on the Powder Diffraction beamline at the Australian Synchrotron.

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